

[本期目录](#) | [下期目录](#) | [过刊浏览](#) | [高级检索](#)[\[打印本页\]](#) [\[关闭\]](#)**研究论文****磁控溅射制备SiC薄膜的高温热稳定性**祝元坤<sup>1</sup>, 朱嘉琦<sup>1</sup>, 韩杰才<sup>1</sup>, 梁军<sup>1</sup>, 张元纯<sup>2</sup>

1. 哈尔滨工业大学复合材料研究所 哈尔滨 150001

2. 中国汽车工业工程公司 天津 300190

**摘要:**

采用磁控溅射方法在Si基底上制备SiC薄膜, 研究了SiC薄膜经不同温度和气氛条件高温退火前后结构、成份的变化。结果表明, 薄膜主要以非晶为主, 由Si--C键, C--C键和少量Si的氧化物杂质组成; 在真空条件下经高温退火后, 薄膜C--C键的含量减少, 而Si--C键的含量增加, 真空退火有利于SiC的形成; 在800℃空气中退火后, 薄膜表面生成一层致密的SiO<sub>2</sub>薄层, 阻止了氧气与薄膜内部深层的接触, 有效保护了内部的SiC。在空气条件下, SiC薄膜在800℃具有较好的热稳定性。

关键词: 无机非金属材料 磁控溅射 热稳定性 高温退火 SiC薄膜

**High-temperature thermal stability research on SiC thin films by magnetron sputtering**ZHU Yuankun<sup>1</sup>, ZHU Jiaqi<sup>1</sup>, HAN Jiecai<sup>1</sup>, LIANG Jun<sup>1</sup>, ZHANG Yuanchun<sup>2</sup>

1. Center for Composite Materials, Harbin Institute of Technology, Harbin 150001

2. China Automobile Industry Engineering Cooperation, Tianjin 300190

**Abstract:**

SiC thin films were grown on Si substrates by magnetron sputtering. The structural and component changes of the films, pre and post high temperature annealing at different temperature and atmosphere conditions, were studied. The results show that the films are characterized by the amorphous microstructure and mainly composed of Si-C bondings, C-C bondings as well as a small mount of oxide impurity consorted with Si; the content of the C-C bondings decreased after annealing in vacuum, meanwhile the Si-C bondings content increased, annealing in vacuum is beneficial to the formation of SiC; after annealing at 800 °C in air, a thin dense layer of SiO<sub>2</sub> formed on the surface, which prevented the oxygen from contacting with the film and effectively protected the inner SiC from oxidizing. SiC films have good thermal stability at 800 °C in air.

Keywords: inorganic non--metallic materials magnetron sputtering thermal stability high-temperature annealing SiC films

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通讯作者: 朱嘉琦

作者简介:

作者Email: zhujq@hit.edu.cn

**参考文献:**

- 1 H.Morkoe, S.Strite, G.B.Gao, Large-band-gap SiC, III-V nitride, and II-VI ZnSe-based semiconductor device technologies, *Journal Applied Physics*, 76, 1363(1994)

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- 2 ZHAO Juan, WANG Gui, LIU Lang, Oxidation protective behavior of SiC coating for different carbon matrix, Surface Technology, 36(2), 123(2007)  
 (赵娟, 王贵, 刘朗, SiC涂层对不同碳基体氧化防护行为的研究, 表面技术, 36(2), 123(2007))
- 3 S.Zaima, K.Onoda, Y.Koide, Y.Yasuda, Effects of oxidation conditions on electrical properties of SiC-SiO<sub>2</sub> interfaces, J. Appl. Phys., 68, 6304(1999)
- 4 R.M.Todi, K.B.Sundaram, A.P.Warren, K.Scammon, Investigation of oxygen annealing effects on RF sputter deposited SiC thin films, Solid-State Electronics, 50, 1189(2006)
- 5 A.K.Costa, S.S.Camargo, Jr., Amorphous SiC coatings for WC cutting tools, Surface and Coatings Technology, 163, 176(2003)
- 6 M.Zaytouni, J.P.Riviere, M.F.Denanot, J.Allain, Structural characterization of SiC films prepared by dynamic ion mixing, Thin Solid Films, 287(1), 1(2006)
- 7 T.Kaneko, Y.Hosokawa, T.Suga, Low-temperature growth of polycrystalline SiC by catalytic CVD from monomethylsilane, Micr. Eng., (83), 41(2006)
- 8 Inacio Regiani, Milton F. de Souza, Silicon carbide coating of mullite substrates by the CVD technique, Surface and Coatings Technology, 162, 131(2003)
- 9 S.M.Rajab, I.C.Oliveira, M.Massi, H.S.Maciel, S.G.dos Santos Filho, R.D.Mansano, Effect of the thermal annealing on the electrical and physical properties of SiC thin films produced by RF magnetron sputtering, Thin Solid Films, 515(1), 170 (2006)
- 10 Sergei A. Alekseev, Vladimir N. Zaitsev, Jacques Botsoa, Daniel Barbier, Fourier transform infrared spectroscopy and temperature-programmed desorption mass spectrometry study of surface chemistry of porous 6H-SiC, Chem. Mater., 19(9), 2189(2007)
- 11 Bibhu P. Swain, The analysis of carbon bonding environment in HWCVD deposited a-SiC:H films by XPS and Raman spectroscopy, Surface & Coatings Technology, 201, 1589(2006)
- 12 M.Mehregany, C.A.Zorman, SiC MEMS: opportunities and challenges for applications in harsh environments, Thin Solid Films, 355-356, 518(1999)
- 13 Yi Jian, He Xiaodong, Sun Yue, Electron beam-physical vapor deposition of SiC/SiO<sub>2</sub> high emissivity thin film, Applied Surface Science, 253, 4361(2007)
- 14 G.Neuer, G.Jaroma-Weiland, Spectral and total emissivity of high-temperature materials, International Journal of Thermophysics, 19(3), 917(1998)

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- 冯+C3419奇 , 巴恒静, 刘光明 .二级界面对水泥基材料孔结构和性能的影响[J]. 材料研究学报, 2003,17(5): 0-494
- 陈岁元, 刘常升, 张雅静, 才庆魁 .激光辐照丙酮溶液中固体靶制备纳米碳粉[J]. 材料研究学报, 2003,17(5): 0-498
- 张栋杰, 都有为 .Fe<sub>2</sub>O<sub>3</sub>对锌铁氧体隧道结构和磁性能的影响[J]. 材料研究学报, 2004,18(1): 34-
- 顾四朋, 侯立松, 赵启涛 .Sn掺杂Ge--Sb--Te相变薄膜的晶化特性[J]. 材料研究学报, 2004,18(2): 181-186
- 刘旭东, 曹小明, 张洪延, 张劲松 .三维连通网络碳化硅的电特性[J]. 材料研究学报, 2004,18(4): 365-372
- 刘旭东, 邹智敏, 曹小明, 张洪延, 张劲松 .铅酸蓄电池三维网络碳化硅板栅和极板内电流的分布[J]. 材料研究学报, 2004,18(6): 587-592
- 马兆昆, 刘杰 .碳纤维表面特性对兼性及厌氧微生物固着的影响[J]. 材料研究学报, 2004,18(1): 60-
- 黄苏萍, 周科朝, 刘咏 .羟基磷灰石晶体在有机膜上的受控生长[J]. 材料研究学报, 2004,18(1): 66-
- 朱嘉琦, 孟松鹤, 韩杰才, 檀满林 .衬底偏压对四面体非晶碳薄膜结构和性能的影响[J]. 材料研究学报, 2004,18(1): 76-

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